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BUF420AW

HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

- STMicroelectronics PREFERRED SALESTYPE
- HIGH VOLTAGE CAPABILITY
- VERY HIGH SWITCHING SPEED
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- LOW BASE-DRIVE REQUIREMENTS

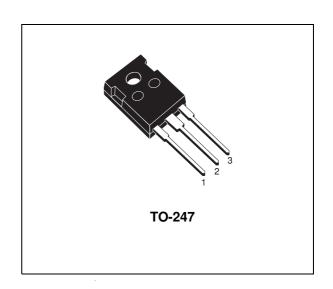
APPLICATIONS:

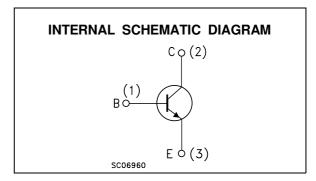
- SWITCH MODE POWER SUPPLIES
- MOTOR CONTROL

DESCRIPTION

The BUF420AW is manufactured using High Voltage Multi Epitaxial Planar technology for high switching speeds and high voltage capacity. It uses a Cellular Emitter structure with planar edge termination to enhance switching speeds while maintaining a wide RBSOA.

The BUF series is designed for use in high-frequency power supplies and motor control applications.





ABSOLUTE MAXIMUM RATINGS

| Symbol | Parameter | Value | Unit |
|------------------|---|------------|------|
| V _{CEV} | Collector-Emitter Voltage (V _{BE} = -1.5V) | 1000 | V |
| V _{CEO} | Collector-Emitter Voltage (I _B = 0) | 450 | V |
| V _{EBO} | Emitter-Base Voltage (I _C = 0) | 7 | V |
| Ic | Collector Current | 30 | Α |
| I _{CM} | Collector Peak Current (t _p < 5 ms) | 60 | Α |
| I _B | Base Current | 6 | Α |
| I _{BM} | Base Peak Current (t _p < 5 ms) | 9 | Α |
| P _{tot} | Total Dissipation at T _c = 25 °C | 200 | W |
| T _{stg} | Storage Temperature | -65 to 150 | °C |
| Tj | Max. Operating Junction Temperature | 150 | °C |

March 2002 1/8

THERMAL DATA

| R _{thi-case} Thermal Resistance Junction-Case | Max | 0.63 | °C/W |
|--|-----|------|------|
|--|-----|------|------|

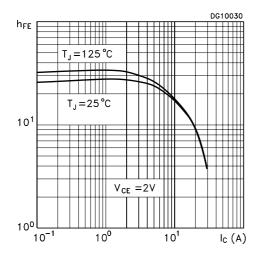
ELECTRICAL CHARACTERISTICS $(T_{case} = 25 \, {}^{o}C)$ unless otherwise specified)

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|--|---|--|-----------|---------------------|------------------|----------------------|
| I _{CER} | Collector Cut-off Current (R _{BE} = 5 Ω) | V _{CE} = 1000 V V _{CE} = 1000 V T _C = 100 °C | | | 0.2 1 | mA mA |
| I _{CEV} | Collector Cut-off Current (V _{BE} = -1.5V) | V _{CE} = 1000 V V _{CE} = 1000 V T _C = 100 °C | | | 0.2 1 | mA mA |
| I _{EBO} | Emitter Cut-off Current (I _C = 0) | V _{EB} = 5 V | | | 1 | mA |
| V _{CEO(sus)} * | Collector-Emitter Sustaining Voltage (I _B = 0) | I _C = 200 mA | 450 | | | V |
| V _{EBO} | Emitter Base Voltage (I _C = 0) | I _E = 50 mA | 7 | | | ٧ |
| V _{CE(sat)} * | Collector-Emitter Saturation Voltage | $\begin{array}{llllllllllllllllllllllllllllllllllll$ | | 0.8 | 2.8 | V V V |
| V _{BE(sat)} * | Base-Emitter Saturation Voltage | $\begin{array}{cccccccccccccccccccccccccccccccccccc$ | | 0.9 | 1.5 | V V V |
| di _c /dt | Rate of rise on-state Collector Current | $\begin{array}{cccccccccccccccccccccccccccccccccccc$ | 70 150 | 100 | | A/μs A/μs A/μs |
| V _{CE} (3μs) | Collector-Emitter Dynamic Voltage | $\begin{array}{cccccccccccccccccccccccccccccccccccc$ | | 2.1 | 8 | V V |
| V _{CE} (5μs) | Collector-Emitter Dynamic Voltage | $\begin{array}{cccccccccccccccccccccccccccccccccccc$ | | 1.1 | 4 | V V |
| t _s t _f t _c | INDUCTIVE LOAD Storage Time Fall Time Cross Over Time | $\begin{array}{lll} I_{C} = 10 \; A & & V_{CC} = 50 \; V \\ V_{BB} = -5 \; V & & R_{BB} = 0.6 \; \; \Omega \\ V_{clamp} = 400 \; V & & I_{B1} = 1 \; A \\ L = 0.25 \; mH & & & \end{array}$ | | 1 0.05 0.08 | | μs μs μs |
| t _s t _f t _c | INDUCTIVE LOAD Storage Time Fall Time Cross Over Time | $\begin{array}{lll} I_{C} = 10 \; A & V_{CC} = 50 \; V \\ V_{BB} = -5 \; V & R_{BB} = 0.6 \; \Omega \\ V_{clamp} = 400 \; V & I_{B1} = 1 \; A \\ L = 0.25 \; mH & T_{C} = 100 ^{o}C \end{array}$ | | | 2 0.1 0.18 | μs μs μs |
| V _{CEW} | Maximum Collector Emitter Voltage without Snubber | $\begin{array}{lll} I_{C} = 10 \; A & V_{CC} = 50 \; V \\ V_{BB} = -5 \; V & R_{BB} = 0.6 \; \Omega \\ I_{B1} = 1 \; A & L = 0.25 \; mH \\ T_{C} = 125 ^{\circ} C & \end{array}$ | 500 | | | V |
| t _s t _f t _c | INDUCTIVE LOAD Storage Time Fall Time Cross Over Time | $\begin{array}{lll} I_{C} = 10 \; A & & V_{CC} = 50 \; V \\ V_{BB} = 0 & & R_{BB} = 0.15 \; \Omega \\ V_{clamp} = 400 \; V & & I_{B1} = 1 \; A \\ L = 0.25 \; mH & & & \end{array}$ | | 1.5 0.04 0.07 | | μs μs μs |

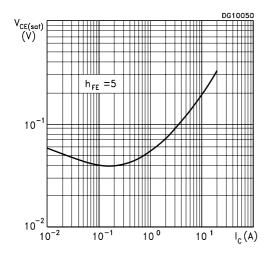
ELECTRICAL CHARACTERISTICS (continued)

| Symbol | Parameter | Test Conditions | | Min. | Тур. | Max. | Unit |
|--|--|--|---|------|---------------------|--------------------|----------------|
| t _s t _f t _c | INDUCTIVE LOAD Storage Time Fall Time Cross Over Time | $I_{C} = 10 \text{ A}$ $V_{BB} = 0$ $V_{clamp} = 400 \text{ V}$ $L = 0.25 \text{ mH}$ | $V_{CC} = 50 \text{ V}$ $R_{BB} = 0.15 \Omega$ $I_{B1} = 1 \text{ A}$ $T_{C} = 100^{\circ}\text{C}$ | | | 3 0.15 0.25 | μs μs μs |
| V _{CEW} | Maximum Collector Emitter Voltage without Snubber | $I_{C} = 10 \text{ A}$ $V_{BB} = 0$ $I_{B1} = 1 \text{ A}$ $T_{C} = 125^{\circ}\text{C}$ | V_{CC} = 50 V R_{BB} = 0.15 Ω L = 0.25 mH | 500 | | | V |
| t _s t _f t _c | INDUCTIVE LOAD Storage Time Fall Time Cross Over Time | I _C = 20 A V _{BB} = -5 V V _{clamp} = 400 V L = 0.12 mH | $V_{CC} = 50 \text{ V}$ $R_{BB} = 0.6 \Omega$ $I_{B1} = 4 \text{ A}$ | | 2.2 0.06 0.12 | | μs μs μs |
| t _s t _f t _c | INDUCTIVE LOAD Storage Time Fall Time Cross Over Time | $I_{C} = 20 \text{ A} \\ V_{BB} = -5 \text{ V} \\ V_{clamp} = 400 \text{ V} \\ L = 0.12 \text{ mH}$ | $V_{CC} = 50 \text{ V}$ $R_{BB} = 0.6 \Omega$ $I_{B1} = 4 \text{ A}$ $T_{C} = 125^{\circ}\text{C}$ | | | 3.5 0.12 0.3 | μs μs μs |
| V _{CEW} | Maximum Collector Emitter Voltage without Snubber | $I_{CWoff} = 30 \text{ A}$ $V_{BB} = -5 \text{ V}$ $L = 0.12 \text{ mH}$ $T_C = 125^{\circ}\text{C}$ | $V_{CC} = 50 \text{ V}$ $R_{BB} = 0.6 \Omega$ $I_{B1} = 6 \text{ A}$ | 400 | | | V |

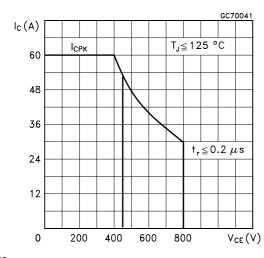
DC Current Gain



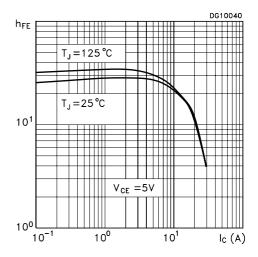
Collector Emitter Saturation Voltage



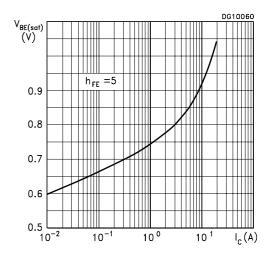
Forward Biased Safe Operating Area



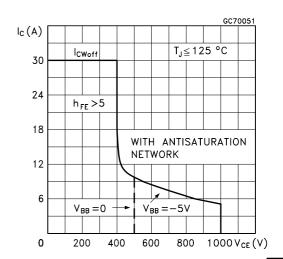
DC Current Gain



Base Emitter Saturation Voltage



Reverse Biased Safe Operating Area



Storage Time Versus Pulse Time.

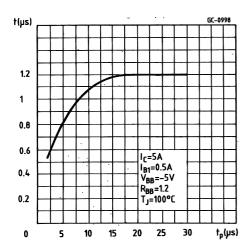
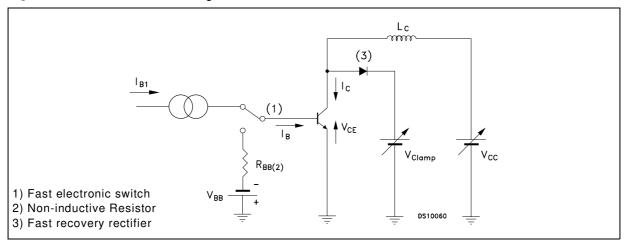
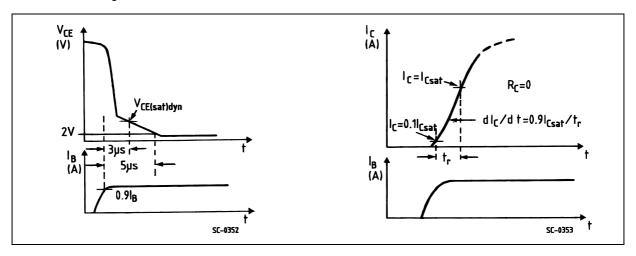


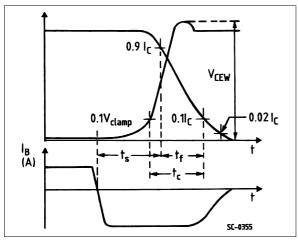
Figure 1: Inductive Load Switching Test Circuit.



Turn-on Switching Test Waveforms.

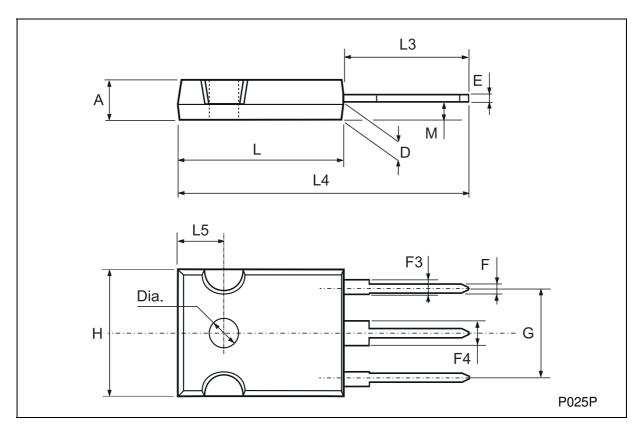


Turn-off Switching Test Waveforms (inductive load).



TO-247 MECHANICAL DATA

| DIM. | | mm | | | inch | |
|------|------|------|------|-------|-------|-------|
| | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| А | 4.7 | | 5.3 | 0.185 | | 0.209 |
| D | 2.2 | | 2.6 | 0.087 | | 0.102 |
| E | 0.4 | | 0.8 | 0.016 | | 0.031 |
| F | 1 | | 1.4 | 0.039 | | 0.055 |
| F3 | 2 | | 2.4 | 0.079 | | 0.094 |
| F4 | 3 | | 3.4 | 0.118 | | 0.134 |
| G | | 10.9 | | | 0.429 | |
| Н | 15.3 | | 15.9 | 0.602 | | 0.626 |
| L | 19.7 | | 20.3 | 0.776 | | 0.779 |
| L3 | 14.2 | | 14.8 | 0.559 | | 0.582 |
| L4 | | 34.6 | | | 1.362 | |
| L5 | | 5.5 | | | 0.217 | |
| М | 2 | | 3 | 0.079 | | 0.118 |



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